

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination EAR, CHENGLIM	
		Examiner /BINH K. TIEU/	Art Unit 2614	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0117602	06-2005	Carrigan et al.	370/466
*	B	US-2004/0252657	12-2004	Lakhani et al.	370/328
*	C	US-2004/0176067	09-2004	Lakhani et al.	455/406
*	D	US-2003/0017819	01-2003	Bantz et al.	455/406
*	E	US-2003/0110044	06-2003	Nix et al.	705/1
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

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